## Applicant(s)/Patent Under Application/Control No. Reexamination 10/787,526 CHANG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1618 D. L. Jones **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-4,016,290 04-1977 Rahman, Yueh Erh 514/566 Α US-В US-С US-D Ε US-F US-US-G US-Н US-1 US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY WO 89/00052 Ν 01-1989 WO Vanderipe 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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